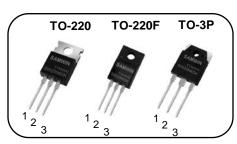


### N-channel Enhanced mode TO-220/TO-220F/TO-3P MOSFET

#### **Features**

- High ruggedness
- Low  $R_{DS(ON)}$  (Typ 0.16 $\Omega$ )@ $V_{GS}$ =10V
- Low Gate Charge (Typ 60nC)
- Improved dv/dt Capability
- 100% Avalanche Tested
- Application:LED, Charge, PC Power



1. Gate 2. Drain 3. Source

# BV<sub>DSS</sub>: 650V I<sub>D</sub>: 20A R<sub>DS(ON)</sub>: 0.16 Ω





## **General Description**

This power MOSFET is produced with advanced technology of SAMWIN. This technology enable the power MOSFET to have better characteristics, including fast switching time, low on resistance, low gate charge and especially excellent avalanche characteristics.

#### **Order Codes**

Item	Sales Type	Marking	Package	Packaging
1	SW P 20N65K	SW20N65K	TO-220	TUBE
2	SW F 20N65K	SW20N65K	TO-220F	TUBE
3	SW W 20N65K	SW20N65K	TO-3P	TUBE

#### **Absolute maximum ratings**

0 1 1	Parameter		Value			Ī
Symbol			TO-220	TO-220F	TO-3P	Unit
V <sub>DSS</sub>	Drain to source voltage		650			V
	Continuous drain current (@T <sub>C</sub> =25°C)		20*			А
l <sub>D</sub>	Continuous drain current (@T <sub>C</sub> =100°C)		12.6*			Α
I <sub>DM</sub>	Drain current pulsed (note 1)		80			А
V <sub>GS</sub>	Gate to source voltage ±30		±30		V	
E <sub>AS</sub>	Single pulsed avalanche energy (note 2) 500		500		mJ	
E <sub>AR</sub>	Repetitive avalanche energy (note 1) 24		24		mJ	
dv/dt	Peak diode recovery dv/dt	(note 3)	5		V/ns	
Б	Total power dissipation (@T <sub>C</sub> =25°C)		341.5	35.9	403.2	W
$P_{D}$	Derating factor above 25°C		2.7	0.3	3.2	W/ºC
T <sub>STG</sub> , T <sub>J</sub>	Operating junction temperature & storage temperature		-55 ~ + 150			°C
TL	Maximum lead temperature for soldering purpose, 1/8 from case for 5 seconds.		300			°C

<sup>\*.</sup> Drain current is limited by junction temperature.

#### Thermal characteristics

Cumbal	Parameter	Value			l loit
Symbol		TO-220	TO-220F	TO-3P	Unit
R <sub>thjc</sub>	Thermal resistance, Junction to case	0.36	3.48	0.31	°C/W
R <sub>thja</sub>	Thermal resistance, Junction to ambient	55.7	47.3	41.6	°C/W



# **Electrical characteristic** ( $T_C = 25^{\circ}C$ unless otherwise specified )

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Off charact	teristics					_
BV <sub>DSS</sub>	Drain to source breakdown voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	650			V
ΔBV <sub>DSS</sub> /ΔT <sub>J</sub>	Breakdown voltage temperature coefficient	I <sub>D</sub> =250uA, referenced to 25°C		0.64		V/°C
	Drain to source leakage current	V <sub>DS</sub> =650V, V <sub>GS</sub> =0V			1	uA
I <sub>DSS</sub>		V <sub>DS</sub> =520V, T <sub>C</sub> =125°C			50	uA
	Gate to source leakage current, forward	V <sub>GS</sub> =30V, V <sub>DS</sub> =0V	(5	2)	100	nA
I <sub>GSS</sub>	Gate to source leakage current, reverse	V <sub>GS</sub> =-30V, V <sub>DS</sub> =0V			-100	nA
On charact	teristics	0 4		•	•	•
V <sub>GS(TH)</sub>	Gate threshold voltage	$V_{DS}=V_{GS}$ , $I_{D}=250uA$	2		5	V
R <sub>DS(ON)</sub>	Drain to source on state resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =10A		0.16	0.19	Ω
G <sub>fs</sub>	Forward transconductance	V <sub>DS</sub> =30V, I <sub>D</sub> =10A		14		S
Dynamic c	haracteristics		1			
C <sub>iss</sub>	Input capacitance		7	2170		
C <sub>oss</sub>	Output capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1MHz	1	1470		pF
C <sub>rss</sub>	Reverse transfer capacitance			27		
t <sub>d(on)</sub>	Turn on delay time			28		
t <sub>r</sub>	Rising time	$V_{DS}$ =325V, $I_{D}$ =20A , $R_{G}$ =25 $\Omega$ ,		52		ns
t <sub>d(off)</sub>	Turn off delay time	V <sub>GS</sub> =10V (note 4,5)		116		
t <sub>f</sub>	Fall time			40		
$Q_g$	Total gate charge			60		
$Q_{gs}$	Gate-source charge	$V_{DS}$ =520V, $V_{GS}$ =10V, $I_{D}$ =20A (note 4,5)		17		nC
$Q_{gd}$	Gate-drain charge	(	_	26		

#### Source to drain diode ratings characteristics

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Is	Continuous source current	Integral reverse p-n Junction			20	Α
I <sub>SM</sub>	Pulsed source current	diode in the MOSFET			80	Α
V <sub>SD</sub>	Diode forward voltage drop.	I <sub>S</sub> =20A, V <sub>GS</sub> =0V			1.4	V
t <sub>rr</sub>	Reverse recovery time	I <sub>S</sub> =20A, V <sub>GS</sub> =0V,		366		ns
Q <sub>rr</sub>	Reverse recovery charge	dl <sub>F</sub> /dt=100A/us		6.8		uC

#### . Notes

- Repeatitive rating : pulse width limited by junction temperature.
- L = 62.5mH,  $I_{AS}$  = 4A,  $V_{DD}$  = 50V,  $R_{G}$ =25Ω, Starting  $T_{J}$  = 25°C  $I_{SD}$  ≤ 20A, di/dt = 100A/us,  $V_{DD}$  ≤ BV<sub>DSS</sub>, Staring  $T_{J}$  =25°C Pulse Test : Pulse Width ≤ 300us, duty cycle ≤ 2%
- 3.
- 4.
- Essentially independent of operating temperature.

Fig. 1. On-state characteristics

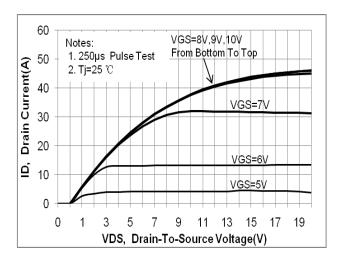


Fig. 3. Gate charge characteristics

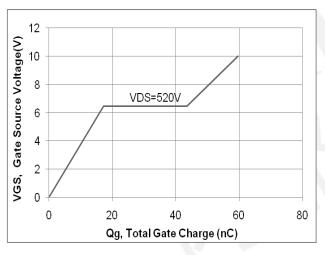


Fig 5. Breakdown Voltage Variation vs. Junction Temperature

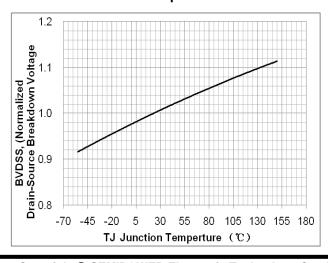


Fig. 2. On-resistance variation vs. drain current and gate voltage

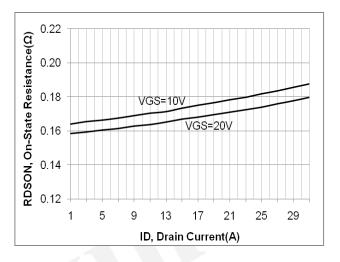


Fig. 4. On state current vs. diode forward voltage

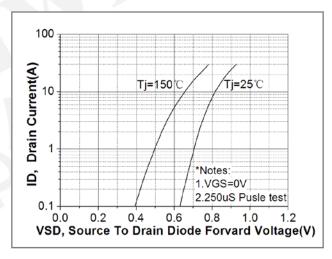


Fig. 6. On resistance variation vs. junction temperature

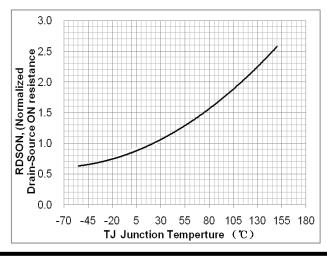


Fig. 7. Maximum safe operating area(TO-220)

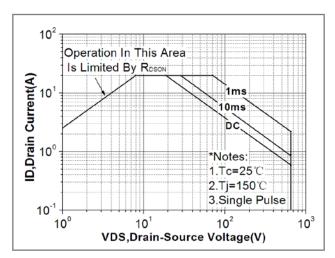


Fig. 9. Maximum safe operating area(TO-3P)

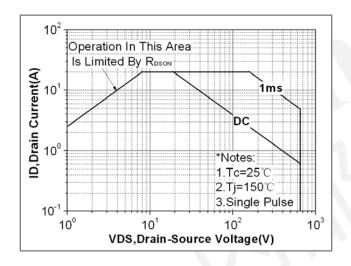


Fig. 11. Transient thermal response curve(TO-220)



Fig. 8. Maximum safe operating area(TO-220F)

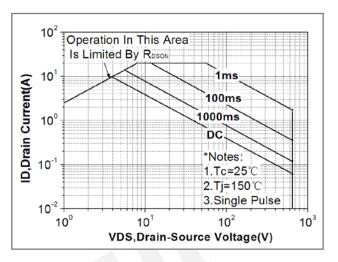


Fig. 10. Capacitance Characteristics

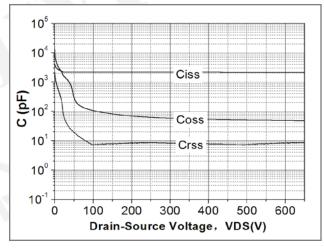


Fig. 12. Transient thermal response curve(TO-220F)

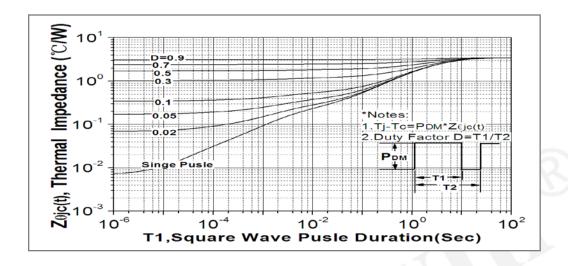


Fig. 13. Transient thermal response curve(TO-3P)

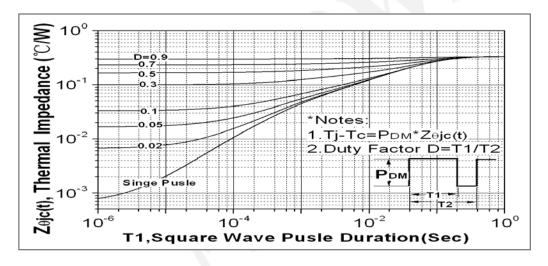


Fig. 14. Gate charge test circuit & waveform

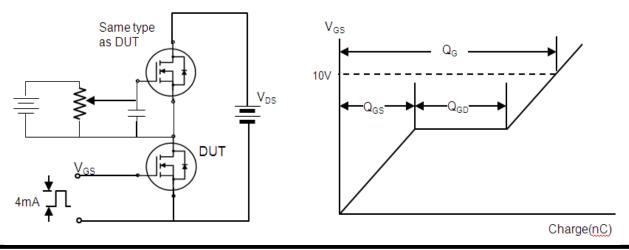


Fig. 15. Switching time test circuit & waveform

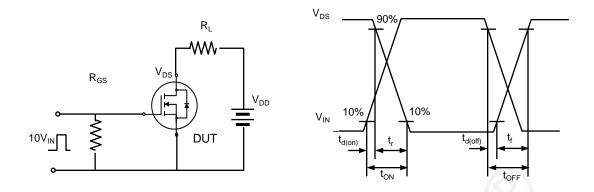


Fig. 16. Unclamped Inductive switching test circuit & waveform

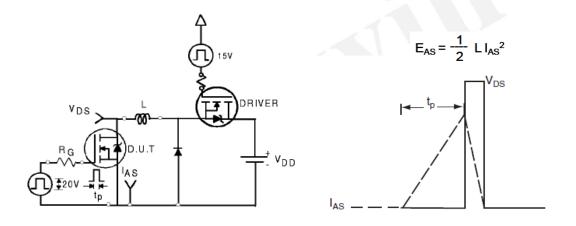
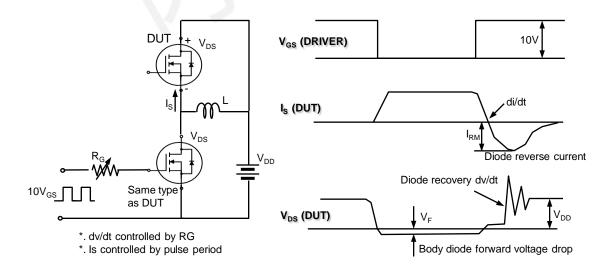


Fig. 17. Peak diode recovery dv/dt test circuit & waveform





#### **DISCLAIMER**

- \* All the data & curve in this document was tested in XI'AN SEMIPOWER TESTING & APPLICATION CENTER.
- \* This product has passed the PCT,TC,HTRB,HTGB,HAST,PC and Solderdunk reliability testing.
- \* Qualification standards can also be found on the Web site (http://www.semipower.com.cn)



\* Suggestions for improvement are appreciated, Please send your suggestions to samwin@samwinsemi.com